Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination OCHIAI, KIYOE	
10/751,734		
Examiner	Art Unit	
Flias R. Hinny	2837	

SEARCHED				
Class	Subclass	Date	Examiner	
318	34	9/21/2005	ЕН	
318	112	9/21/2005	EH -	
318	. 41	10/5/2005	EH	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted on updated search findings and applicants amendment with SPE David Martin.	9/30/2005	EH
Requested fast and focused search from STIC	9/30/2005	EH
Searched US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT;IBM_TDB	9/21/2005	Εμ
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